

Search Notes

Application/Control No.

10/807,072

Examiner

John A. Tweel, Jr.

Applicant(s)/Patent under
Reexamination

EGBERT ET AL.

Art Unit

2612

SEARCHED

Class	Subclass	Date	Examiner
340	572.7	8/11/2006	JAT
	572.1	8/11/2006	JAT
	572.4	8/11/2006	JAT
	572.5	8/11/2006	JAT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR